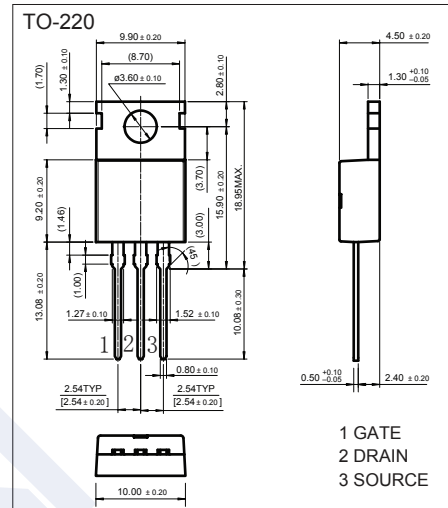
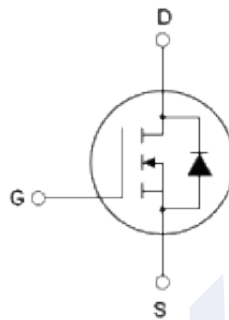


N-Channel MOSFET

KI20N65

■ Features

- V_{DS} (V) = 650V
- I_D = 20A
- $R_{DS(ON)} < 190m\Omega$ @ $V_{GS}=10V$

■ Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current	I_D	$T_c = 25^\circ\text{C}$	20
		$T_c = 100^\circ\text{C}$	12.5
Pulsed Drain Current (Note 1)	I_{DM}	80	A
Avalanche Current (Note 1)	I_{AR}	10.5	A
Single Pulse Avalanche Energy (Note 2)	E_{AS}	441	mJ
Repetitive Avalanche energy, t_{AR} limited by T_{jmax} (Note 1)	E_{AR}	0.7	mJ
Drain Source voltage slope, $V_{DS} \leq 480$ V	dv/dt	50	V/ns
Reverse diode dv/dt , $V_{DS} \leq 480$ V, $I_{SD} < I_D$	dv/dt	15	V/ns
Power Dissipation ($T_c = 25^\circ\text{C}$)	P_D	188	W
Derate above 25°C		1.5	W/ $^\circ\text{C}$
Thermal Resistance, Junction- to-Case	R_{thJC}	0.66	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction- to-Ambient	R_{thJA}	62.5	$^\circ\text{C}/\text{W}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 to 150	$^\circ\text{C}$

Notes: 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2. $T_j=25^\circ\text{C}$, $V_{DD}=50\text{V}$, $V_G=10\text{V}$, $R_G=25\Omega$

N-Channel MOSFET

KI20N65

■ Electrical Characteristics ($T_A = 25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	650			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=650\text{V}$, $V_{GS}=0\text{V}$, $T_C=25^\circ\text{C}$			1	μA
		$V_{DS}=650\text{V}$, $V_{GS}=0\text{V}$, $T_C=125^\circ\text{C}$			100	
Gate-Body Leakage Current	I_{GSS}	$V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	2		4	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}$, $I_D=10\text{A}$			190	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=20\text{V}$, $I_D=10\text{A}$		16		S
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, $f=1\text{MHz}$		2250		μF
Output Capacitance	C_{oss}			83		
Reverse Transfer Capacitance	C_{rss}			1.6		
Total Gate Charge	Q_g	$V_{DS}=480\text{V}$, $I_D=20\text{A}$, $V_{GS}=10\text{V}$		36		nC
Gate Source Charge	Q_{gs}			14		
Gate Drain Charge	Q_{gd}			8.5		
Turn-On DelayTime	$t_{d(on)}$	$V_{DS}=380\text{V}$, $I_D=11\text{A}$, $V_{GS}=10\text{V}$, $R_G=4\Omega$		11		ns
Turn-On Rise Time	t_r			6		
Turn-Off DelayTime	$t_{d(off)}$			61		
Turn-Off Fall Time	t_f			4.5		
Body-Diode Continuous Current	I_S	$T_C=25^\circ\text{C}$			20	A
Body-Diode Pulsed Current	I_{SM}				80	
Diode Forward Voltage (Note 1)	V_{SD}	$T_J=25^\circ\text{C}$, $I_{SD}=20\text{A}$, $V_{GS}=0\text{V}$			1.3	V
Reverse Recovery Time (Note 1)	t_{rr}	$T_J=25^\circ\text{C}$, $I_F=20\text{A}$, $di/dt=100\text{A}/\mu\text{s}$		310		nS
Reverse Recovery Charge (Note 1)	Q_{rr}			5		nC
Peak Reverse Recovery Current	I_{rrm}			28		A

N-Channel MOSFET

KI20N65

■ Typical Electrical And Thermal Characteristics

Figure1. Safe operating area

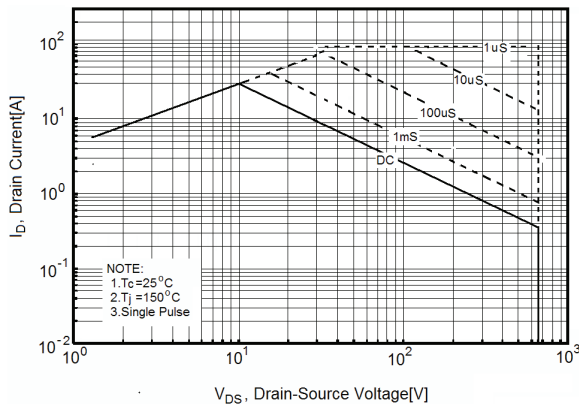


Figure2. Capacitance

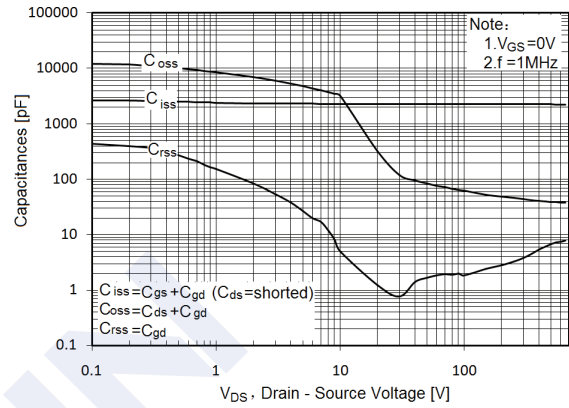


Figure3. Source-Drain Diode Forward Voltage

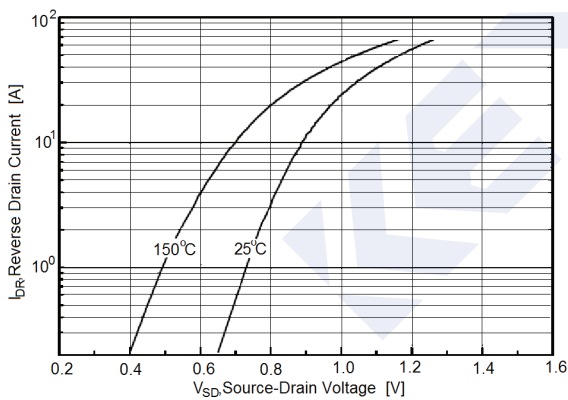


Figure4. Output characteristics

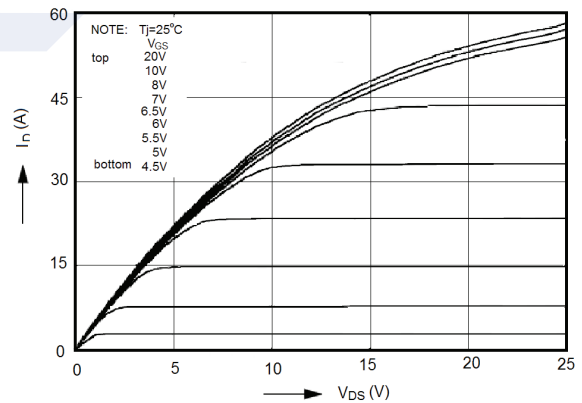


Figure5. Transfer characteristics

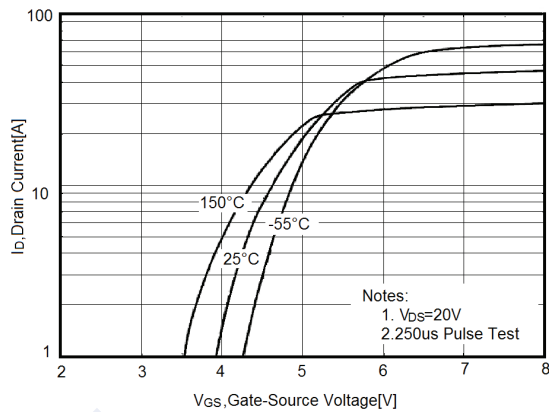
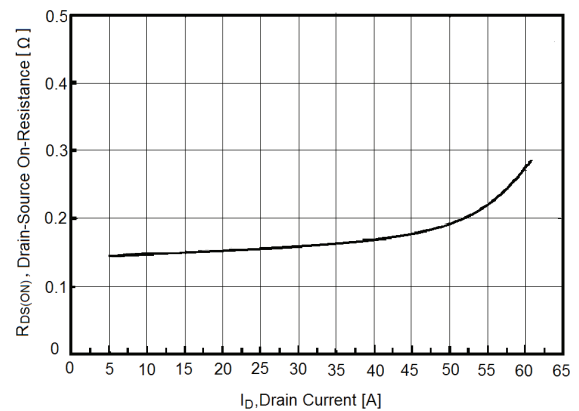


Figure6. Static drain-source on resistance



N-Channel MOSFET

KI20N65

Figure7. $R_{DS(ON)}$ vs Junction Temperature

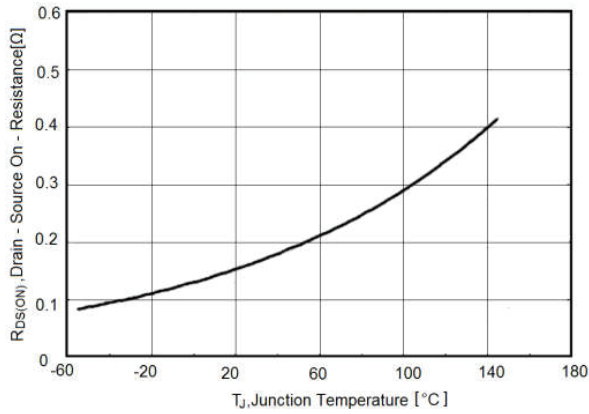


Figure8. BV_{DSS} vs Junction Temperature

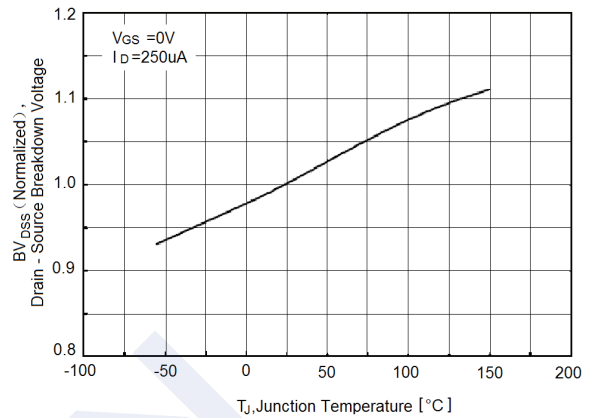


Figure9. Maximum I_D vs Junction Temperature

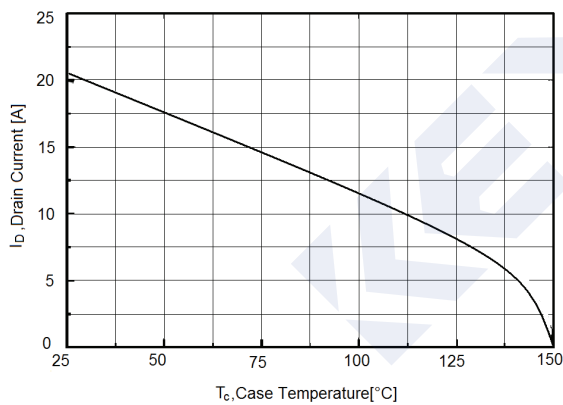


Figure10. Transient Thermal Impedance

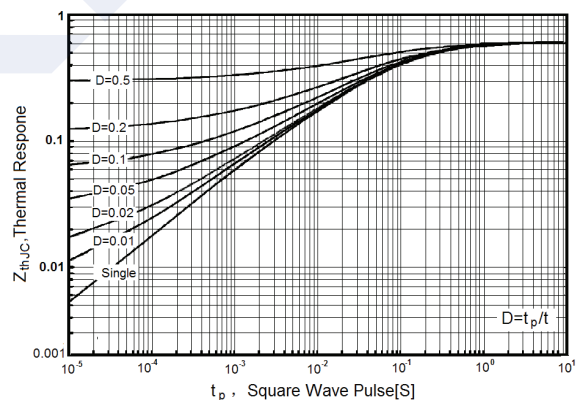
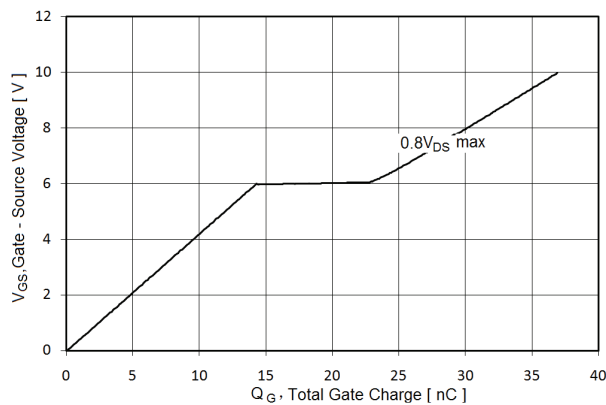


Figure11. Gate charge waveforms

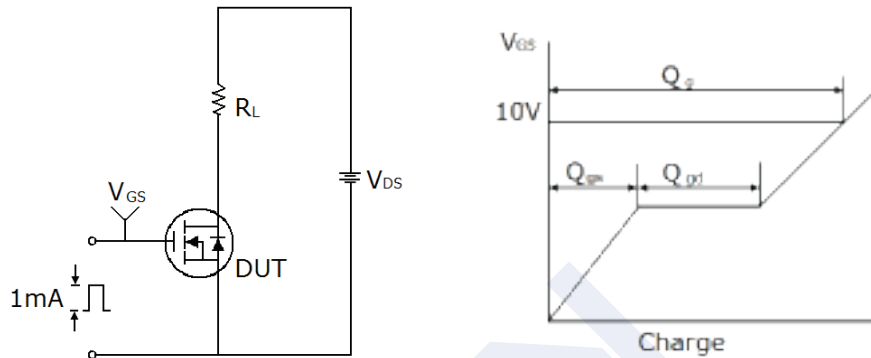


N-Channel MOSFET

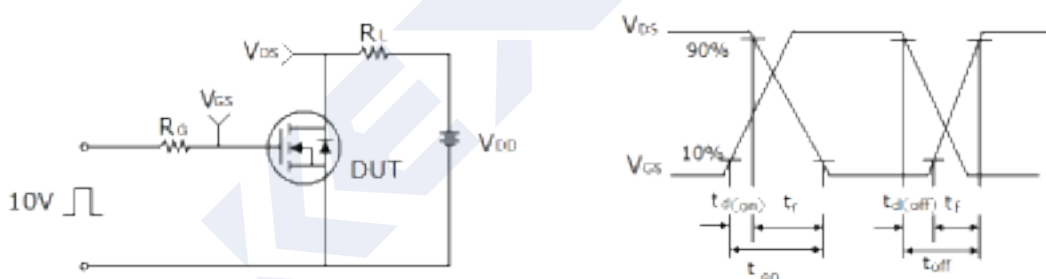
KI20N65

■ Test Circuit

1) Gate charge test circuit & Waveform



2) Switch Time Test Circuit:



3) Unclamped Inductive Switching Test Circuit & Waveforms

